

LMP3117SF 30V P-Channel MOSFET
Features

- -30V/-13.8A, $R_{DS(ON)} < 18m\Omega @ V_{GS} = -10V$
- Fast switching
- Suit for -4.5V Gate Drive Applications
- Green Device Available
- SOP-8 package design

Product Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been

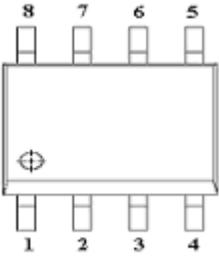
especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

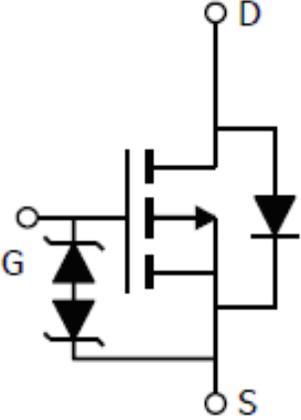
These devices are well suited for high efficiency fast switching applications..

Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Application

Pin Configuration

LMP3117SF (SOP-8)	
	
PIN	Description
1	Source
2	Source
3	Source
4	Gate
5	Drain
6	Drain
7	Drain
8	Drain



Ordering Information

Ordering Information					
Part Number	P/N	PKG code	Pb Free code	Package	Quantity
LMP3117SF	LMP3117	S	F	SOP-8	4000

Marking Information

Marking Information		
Part Marking	Part Number	LFC code
3117SF XWMMMM	3117SF	XWMMMM

Absolute Maximum Ratings

 (T_C=25°C Unless otherwise noted)

Symbol	Parameter	Typical	Unit
V _{DS}	Drain-Source Voltage	-30	V
V _{GS}	Gate-Source Voltage	±25	V
I _D	Continuous Drain Current	T _C =25°C	-13.8
		T _C =70°C	-11.1
		T _A =25°C	-7.8
		T _A =70°C	-6.2
I _{DM}	Pulsed Drain Current	-50	A
P _D	Power Dissipation	T _C =25°C	5.3
		T _C =70°C	3.4
		T _A =25°C	1.7
		T _A =70°C	1.1
T _J	Operating Junction Temperature Range	-55 to +150	°C
T _{STG}	Storage Temperature Range	-55 to +150	°C
R _{θJA}	Thermal Resistance-Junction to Ambient	75	°C/W
R _{θJC}	Thermal Resistance-Junction to Case	24	°C/W

Electrical Characteristics

 (T_C=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250uA	-30			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-1.2		-2.5	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±25V			±100	nA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-30V, V _{GS} =0V			-1	uA
V _{SD}	Diode Forward Voltage ³	V _{GS} =0V, I _S =-1A			-1	V
R _{DSON}	Drain-Source On-Resistance ³	V _{GS} =-10V, I _D =-10A		12.3	18	mΩ
		V _{GS} =-4.5V, I _D =-6A		19.4	26	
Gate charge characteristics						
Q _g	Total Gate Charge ^{3,4}	V _{DD} =-15V, V _{GS} =-4.5V, I _D =-15A		22		nC
Q _{gs}	Gate-Source Charge ^{3,4}			8.7		
Q _{gd}	Gate-Drain Charge ^{3,4}			7.2		
Dynamic characteristics						
C _{iss}	Input Capacitance	V _{DS} =-15V, V _{GS} =0V, f=1.0MHz		2215		pF
C _{oss}	Output Capacitance			310		
C _{rss}	Reverse Transfer Capacitance			237		
t _{d(on)}	Turn-On Time	V _{DD} =-15V, V _{GS} =-10V, R _g =3.3Ω, I _D =-15A		8		ns
t _r	Rise Time			73.7		
t _{d(off)}	Turn-Off Time			61.8		
t _f	Fall Time			24.4		

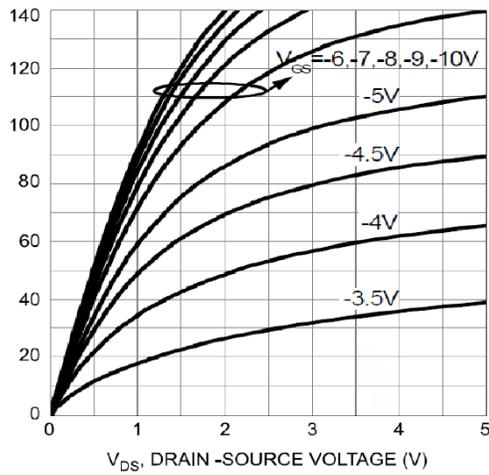
Typical Performance Characteristics


Figure 1. Output Characteristics

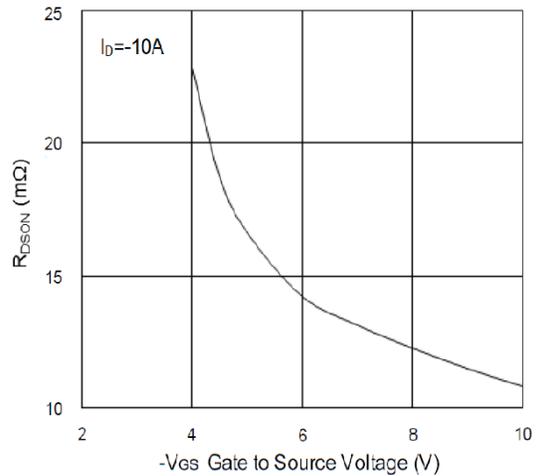
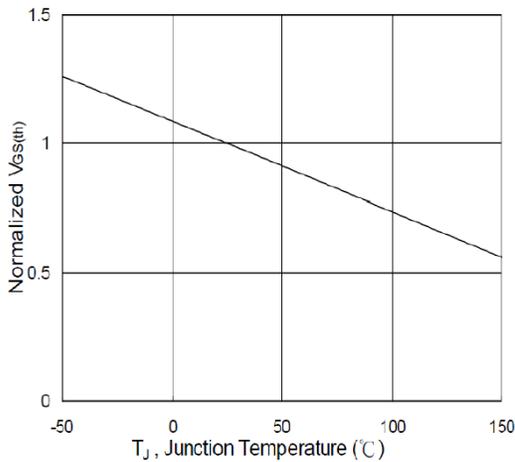
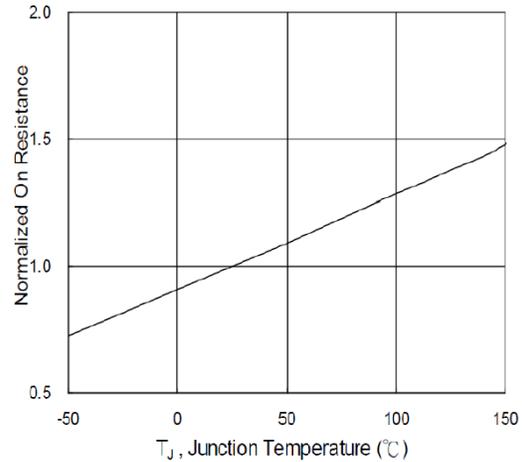
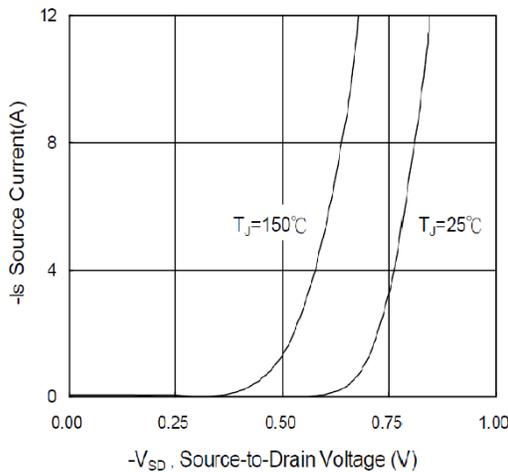

 Figure 2. On-Resistance Variation with V_{GS}

 Figure 3. Normalized $V_{GS(th)}$ vs. T_J

 Figure 4. Normalized R_{DSON} vs. T_J


Figure 5. Diode Forward Voltage vs. Current

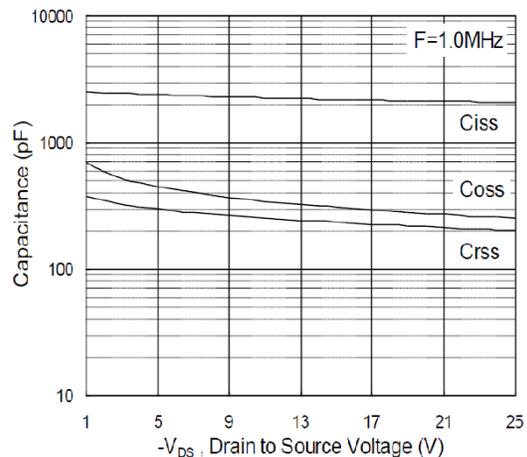


Figure 6. Capacitance

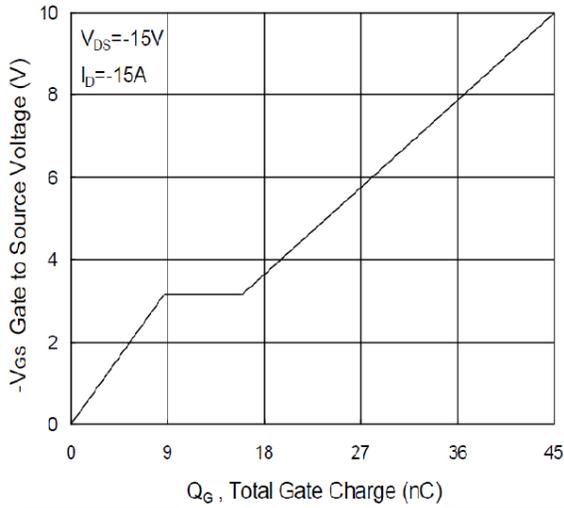
Typical Performance Characteristics(continue)


Figure 7. Gate Charge Waveform

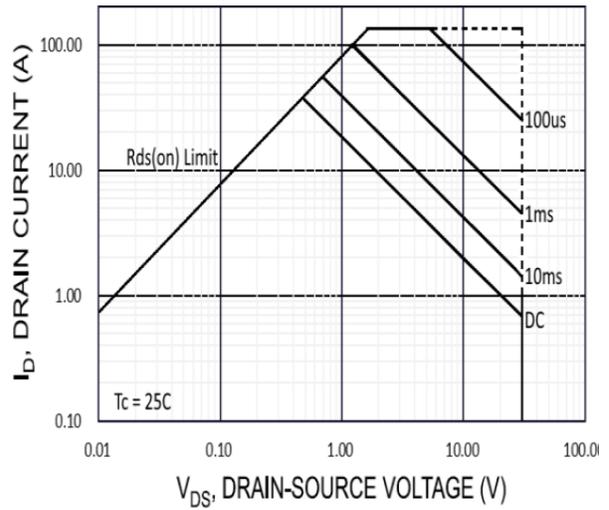


Figure 8. Maximum Safe Operating Area

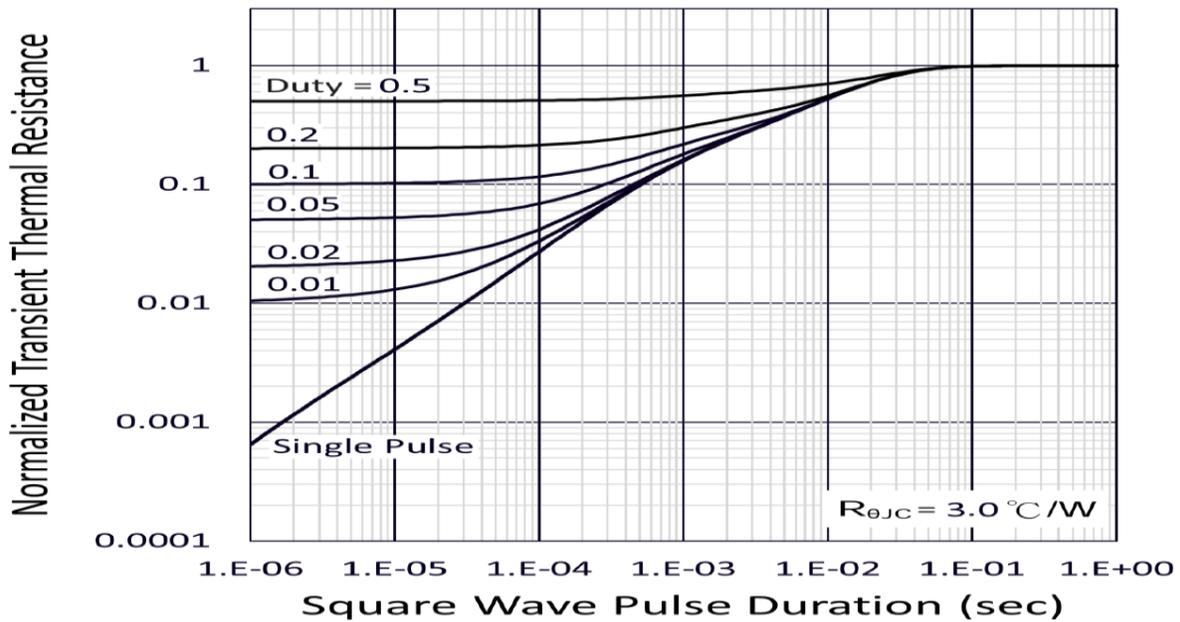
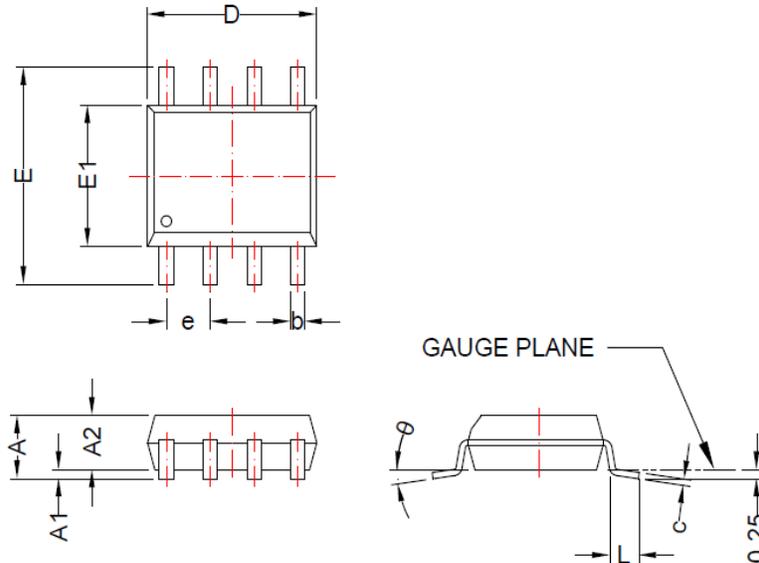


Figure 9. Normalized Transient Thermal Resistance

Package Dimension:
SOP-8


DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER END.
 DIMENSION E1 DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE.

Dimensions				
SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	1.35	1.75	0.053	0.069
A1	0.10	0.25	0.004	0.010
A2	1.25	---	0.049	---
b	0.31	0.51	0.012	0.020
c	0.10	0.26	0.004	0.010
D	4.70	5.10	0.185	0.201
E	5.80	6.20	0.228	0.244
E1	3.70	4.10	0.146	0.161
e	1.27 BSC		0.050 BSC	
L	0.4	1.27	0.016	0.050
θ	0°	8°	0°	8°

NOTICE:

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